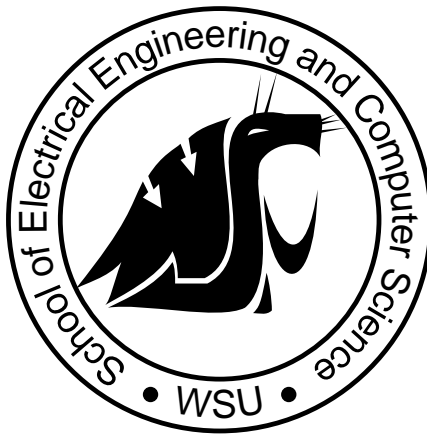
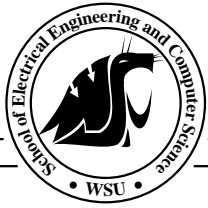


On the Use of an Untapered Plane Wave in Numerical Studies of Scattering from Randomly Rough Surfaces



J. B. Schneider, L. Zhou, S. L. Broschat, Y. Wang
School of Electrical Engineering & Computer Science
Washington State University
Pullman, WA

June 1, 2009

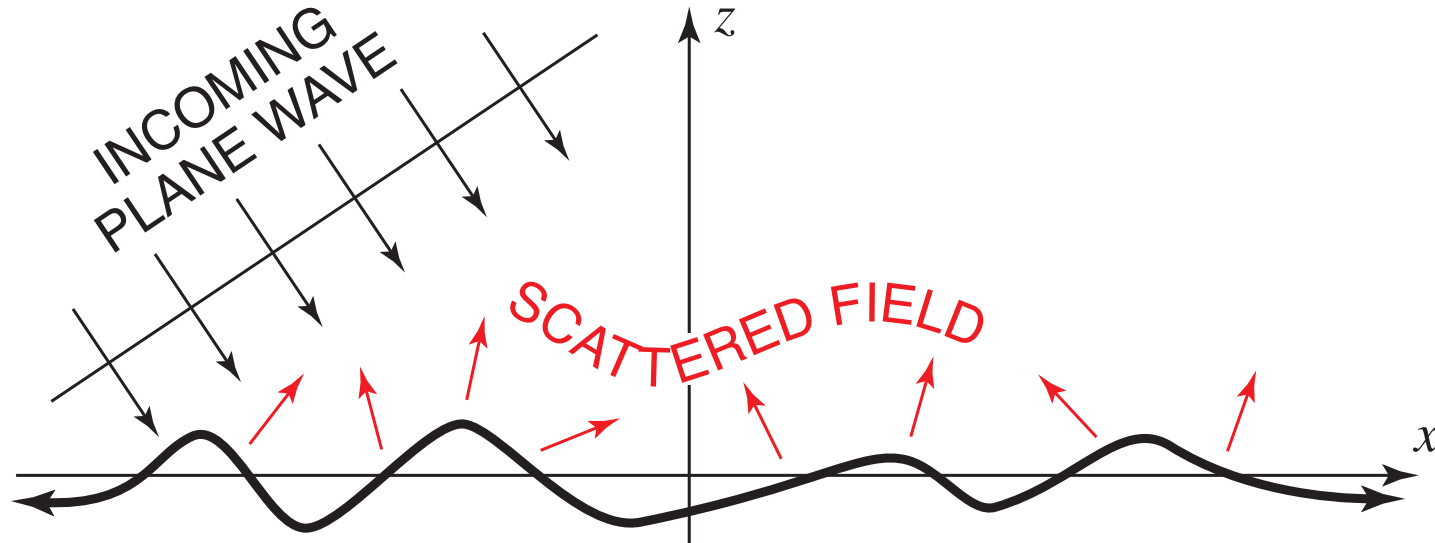


Outline

- General background and problem statement
- Tapered incident field approach
- Plane wave incident field approach
- Scattering from canonical surfaces
- Scattering from randomly rough surfaces
- Conclusions

Note: Concerned with FDTD solutions

Background/Problem Statement

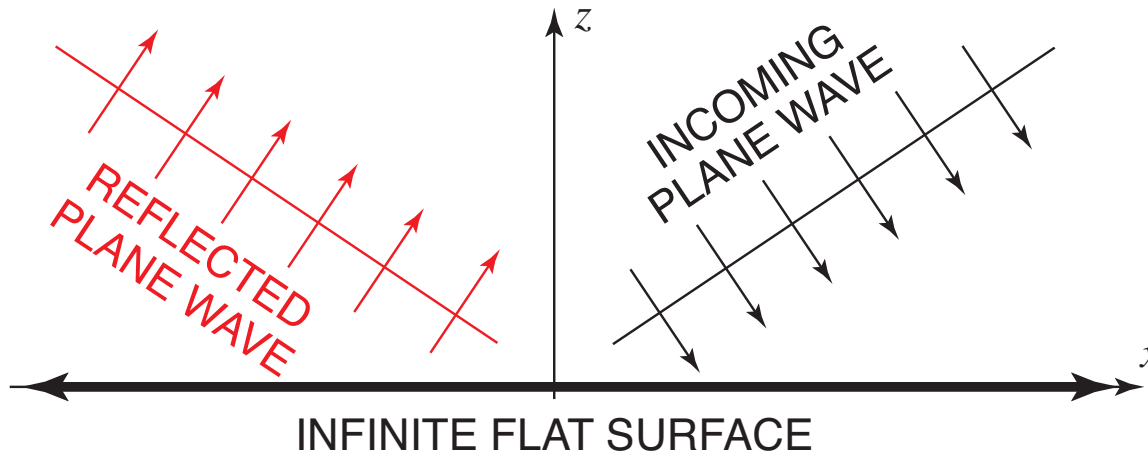


Want scattering from *infinite* randomly rough surface illuminated by plane wave

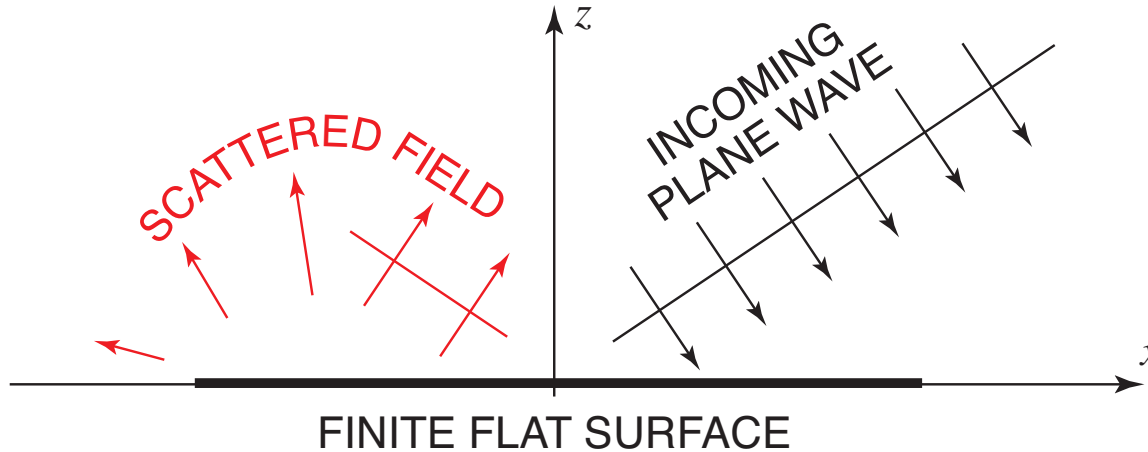
Monte Carlo technique:

- Generate set of *finite* surface realizations
- Determine fields scattered from each realization
- Average results to obtain approximation for infinite surface

Plane Wave Illumination

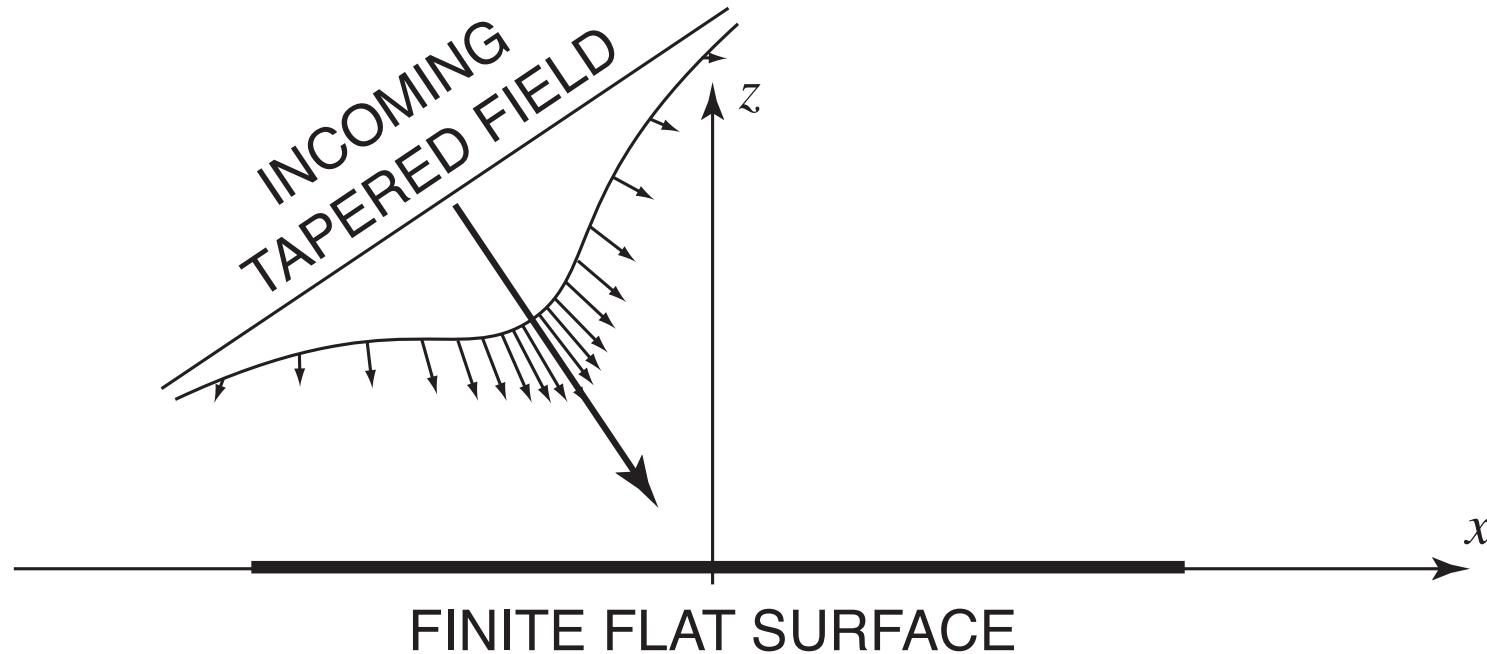


Scattered field is perfect plane wave



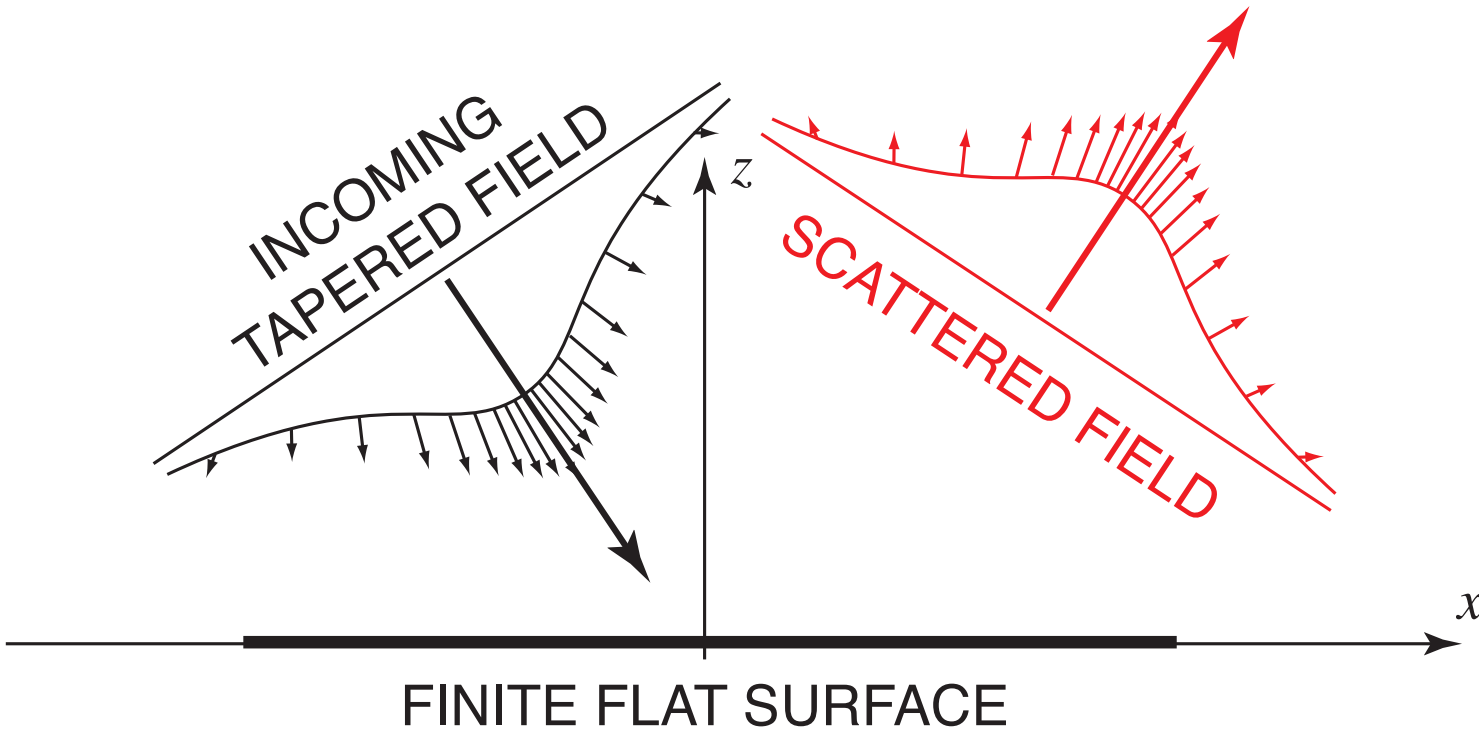
Scattered field includes edge diffraction

Tapered Illumination, I

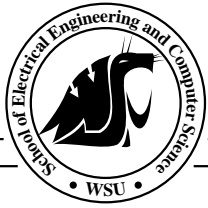


- Tapered illumination ensures incident field small at surface edges
- Effectively eliminates edge diffraction

Tapered Illumination, I

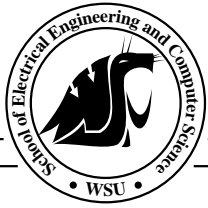


- Tapered illumination ensures incident field small at surface edges
- Effectively eliminates edge diffraction



Tapered Illumination, II

- Approximate solution to wave equation
 - Quality of solution depends on taper factor
 - If *length* of taper fixed, lower frequencies have larger errors
- May require large computational resources to obtain desired field over particular region
- Due to dispersion and anisotropy of FDTD grid, incident angle not exact



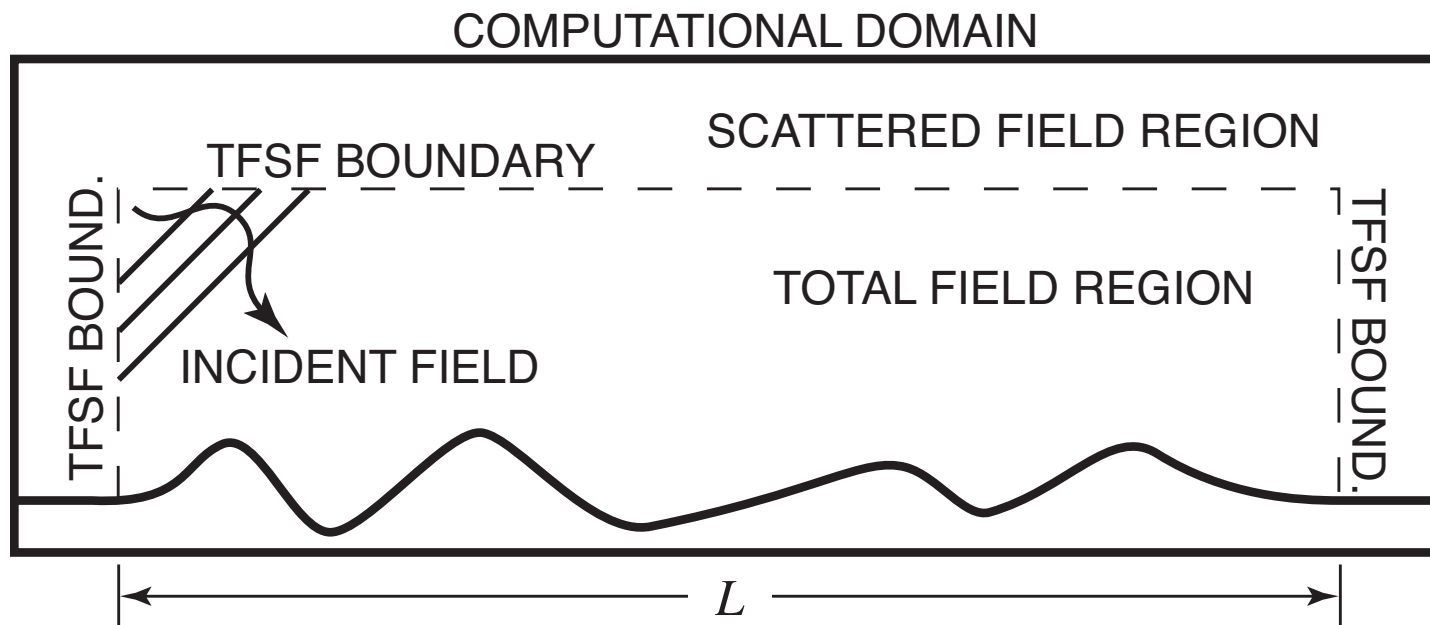
Plane Wave Illumination

Frequency-domain approaches employing plane-wave illumination:

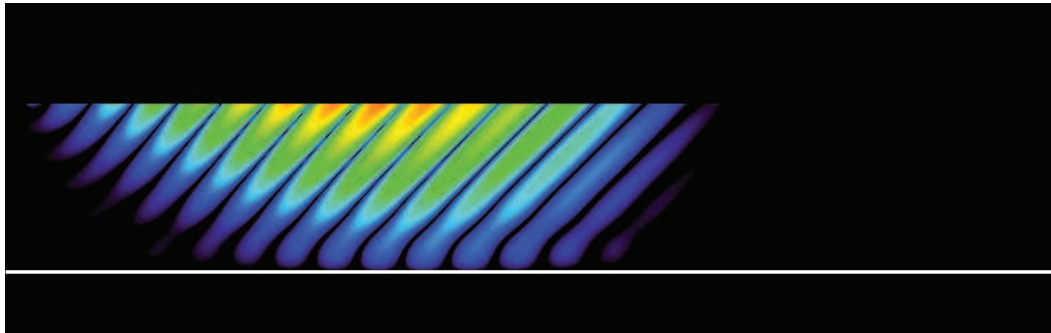
- Y. Oh and K. Sarabandi¹
 - conducting surfaces
 - edge diffraction reduced by adding resistive surfaces to ends
- J. C. West²
 - finite conductivity surfaces
 - diffraction reduced by tapering resistance
- Z. Zhao, L. Li, J. Smith, L. Carin³
 - **used Green's function for conducting half-space**
 - **tapered surface height at ends to match a flat plane**
 - compared half-space and resistive taper approaches

FDTD-Based Solutions

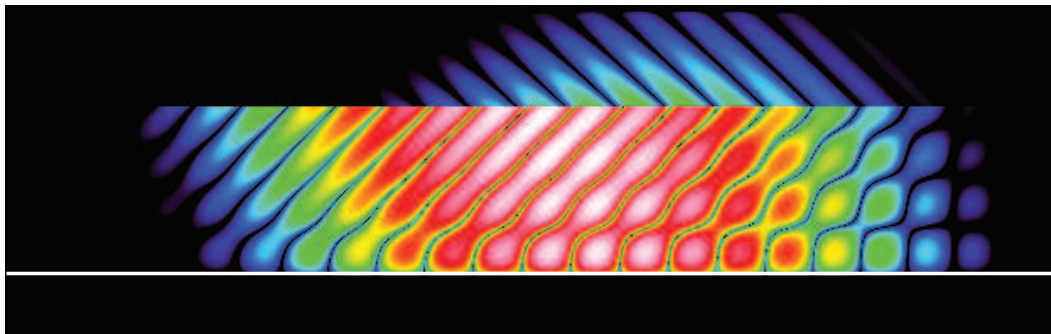
- Differential-equation based method
- Discretize surface and space adjacent to surface
- Incident field introduced over total-field/scattered-field (TFSF) boundary
- Grid divided into scattered-field region and total-field region (incident plus scattered field)



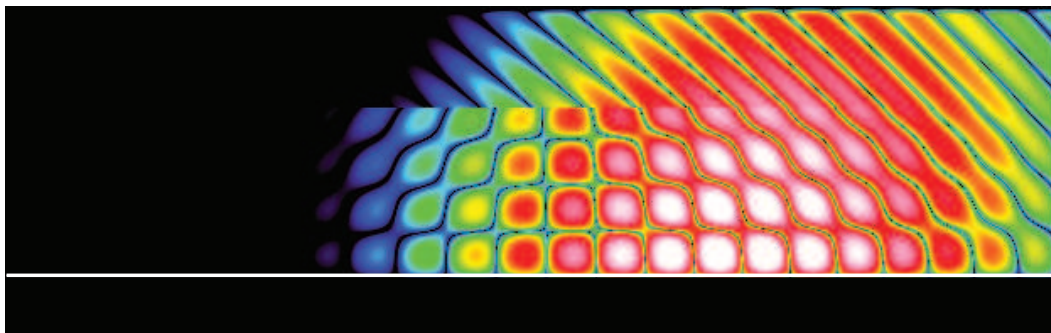
Flat Surface with Tapered Incidence



Snapshot 1: Incoming pulsed beam visible in TF region

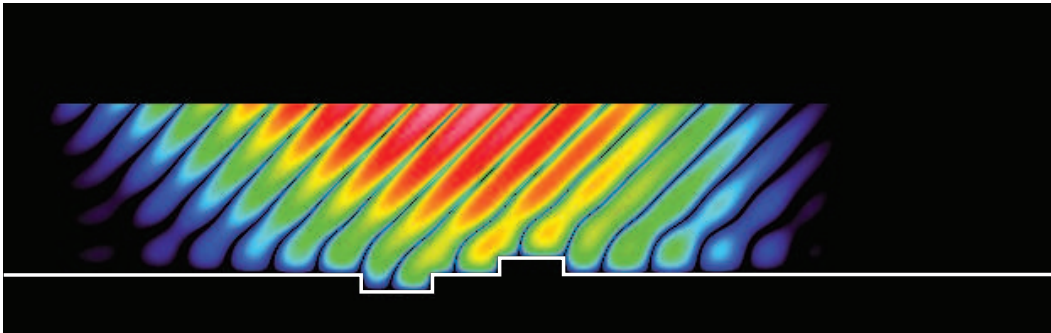


Snapshot 2: Beam reflects; interference visible in TF region; reflected wave seen in SF region

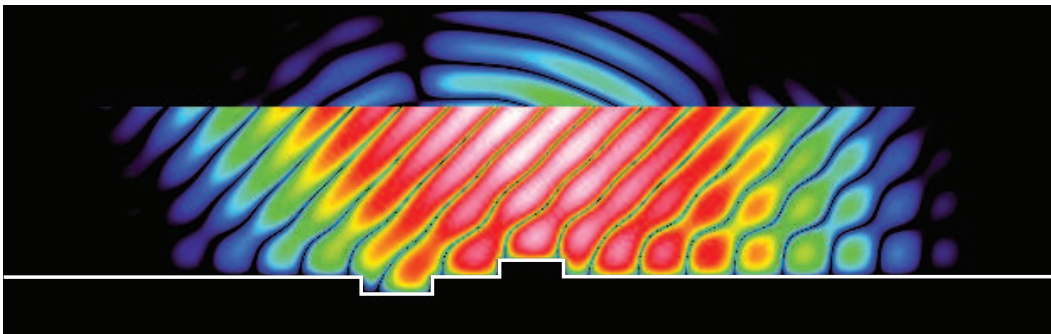


Snapshot 3: Reflected beam a "copy" of incident beam; more visible in SF region

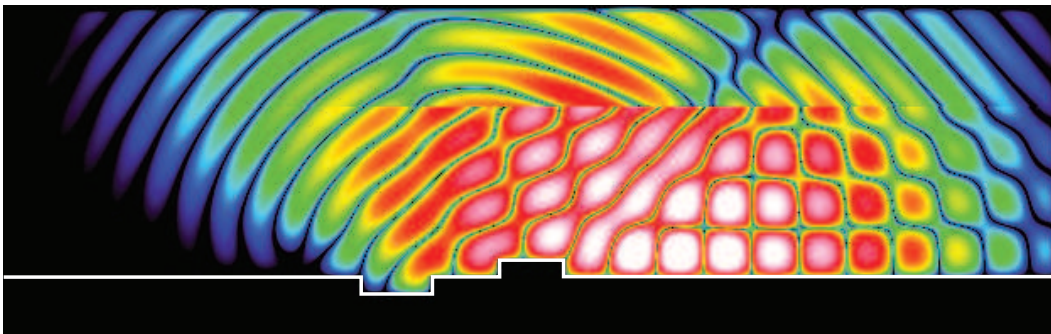
Non-Flat Surface with Tapered Incidence



Snapshot 1: Incident field illuminates notch and bump in surface



Snapshot 2: Scattering from surface visible in SF region

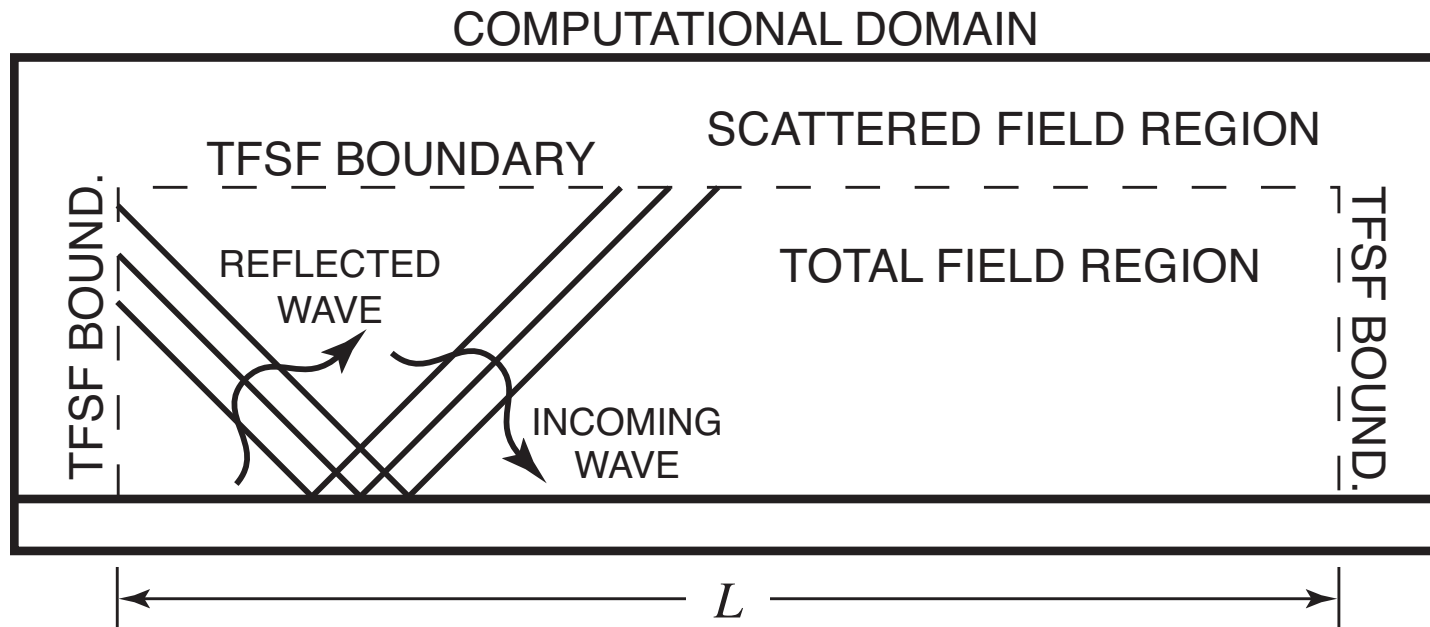


Snapshot 3: Specular reflection now visible in SF region

FDTD-Based Plane Wave Solution

For true plane-wave illumination, incident field composed of:

- (1) incoming plane wave **and**
- (2) corresponding reflected plane wave



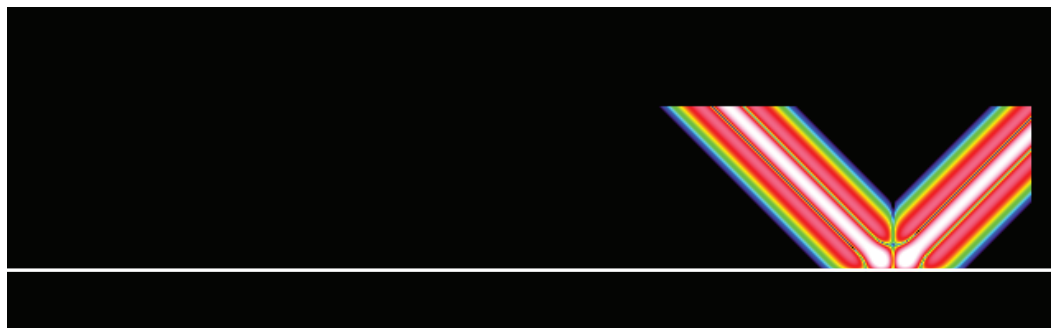
Flat Conducting Surface with Plane Wave Incidence



Snapshot 1: “Incoming” pulsed plane wave visible in TF region

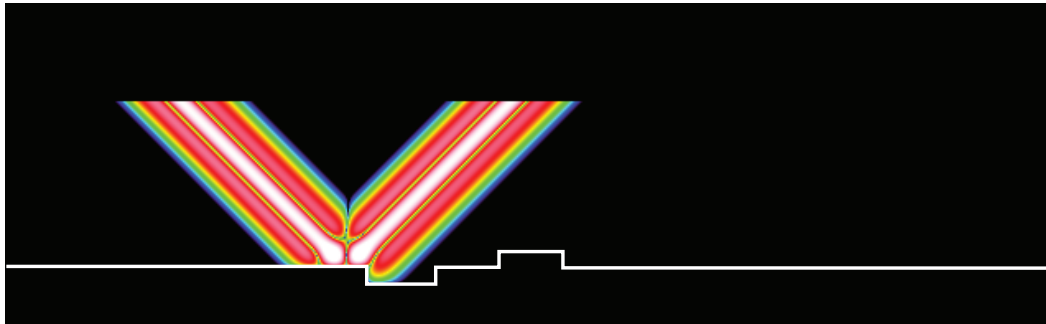


Snapshot 2: Incoming and reflected plane waves visible in TF region

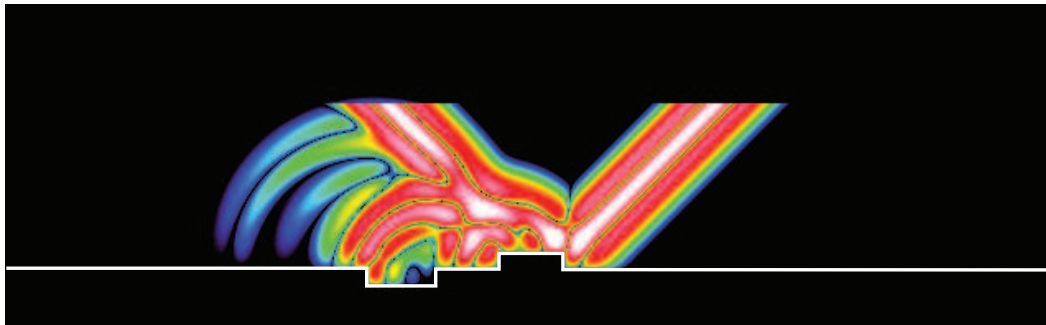


Snapshot 3: For a flat surface, incident field does not escape TF region

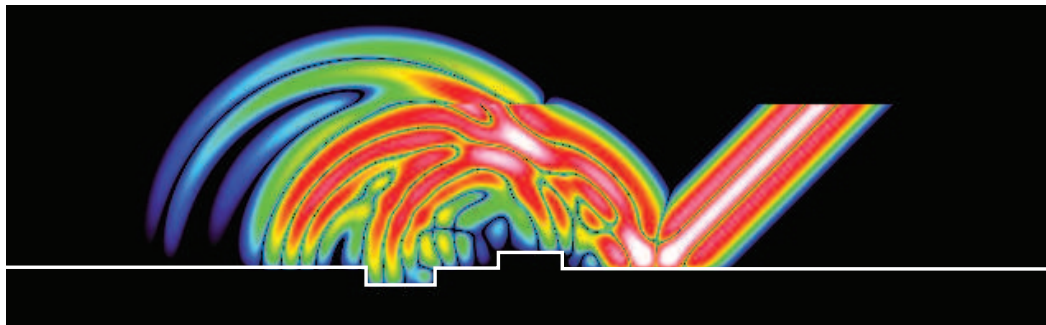
Non-Flat Surface with Plane Wave Incidence



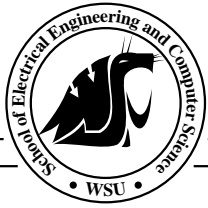
Snapshot 1: Incident field reaches notch in surface illuminated



Snapshot 2: Incident field reaches "bump" in surface

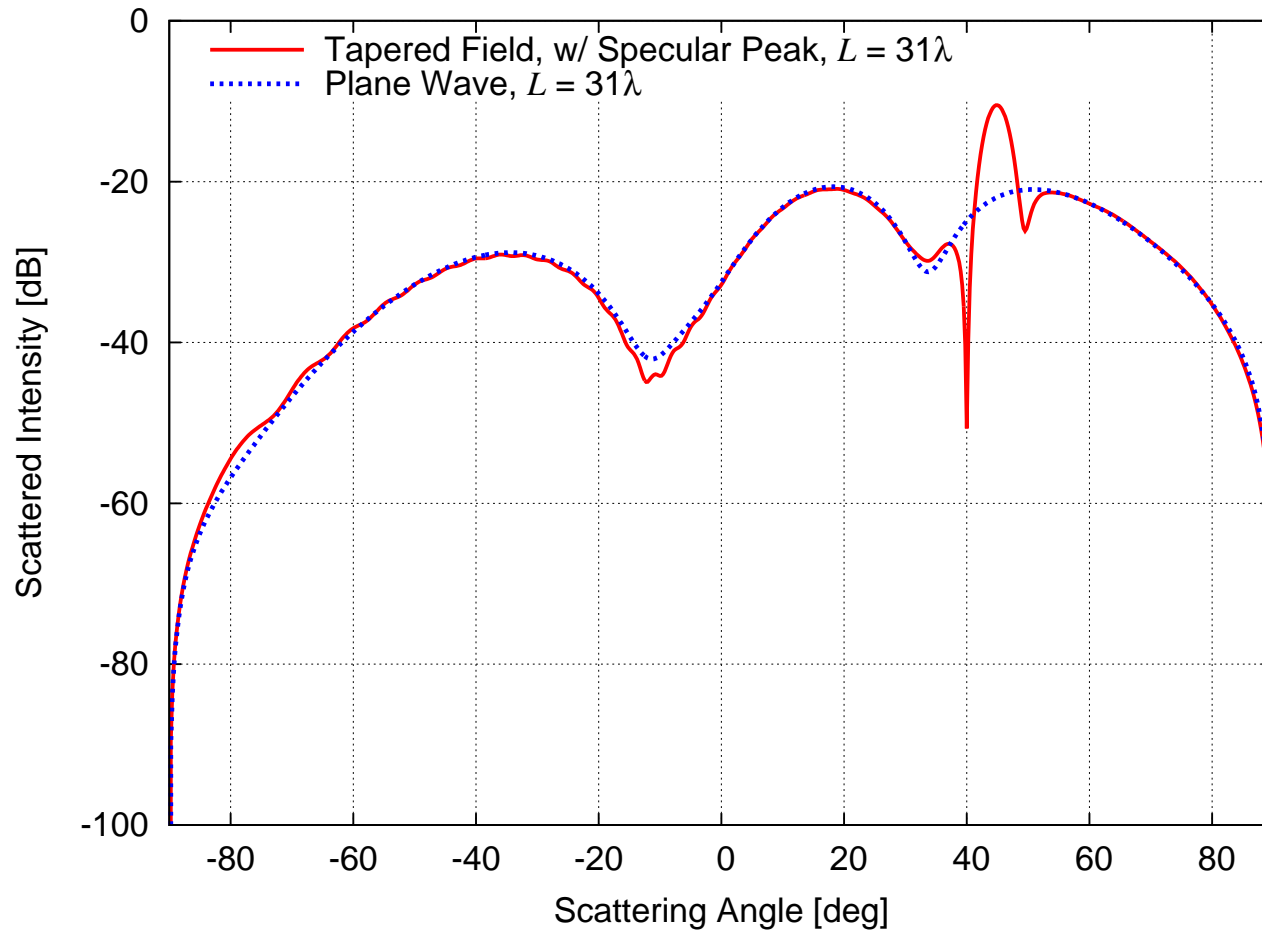


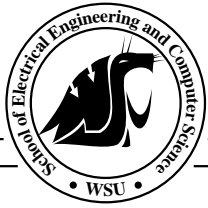
Snapshot 3: Scattered field evident in SF region



Scattering from a Notched Surface, I

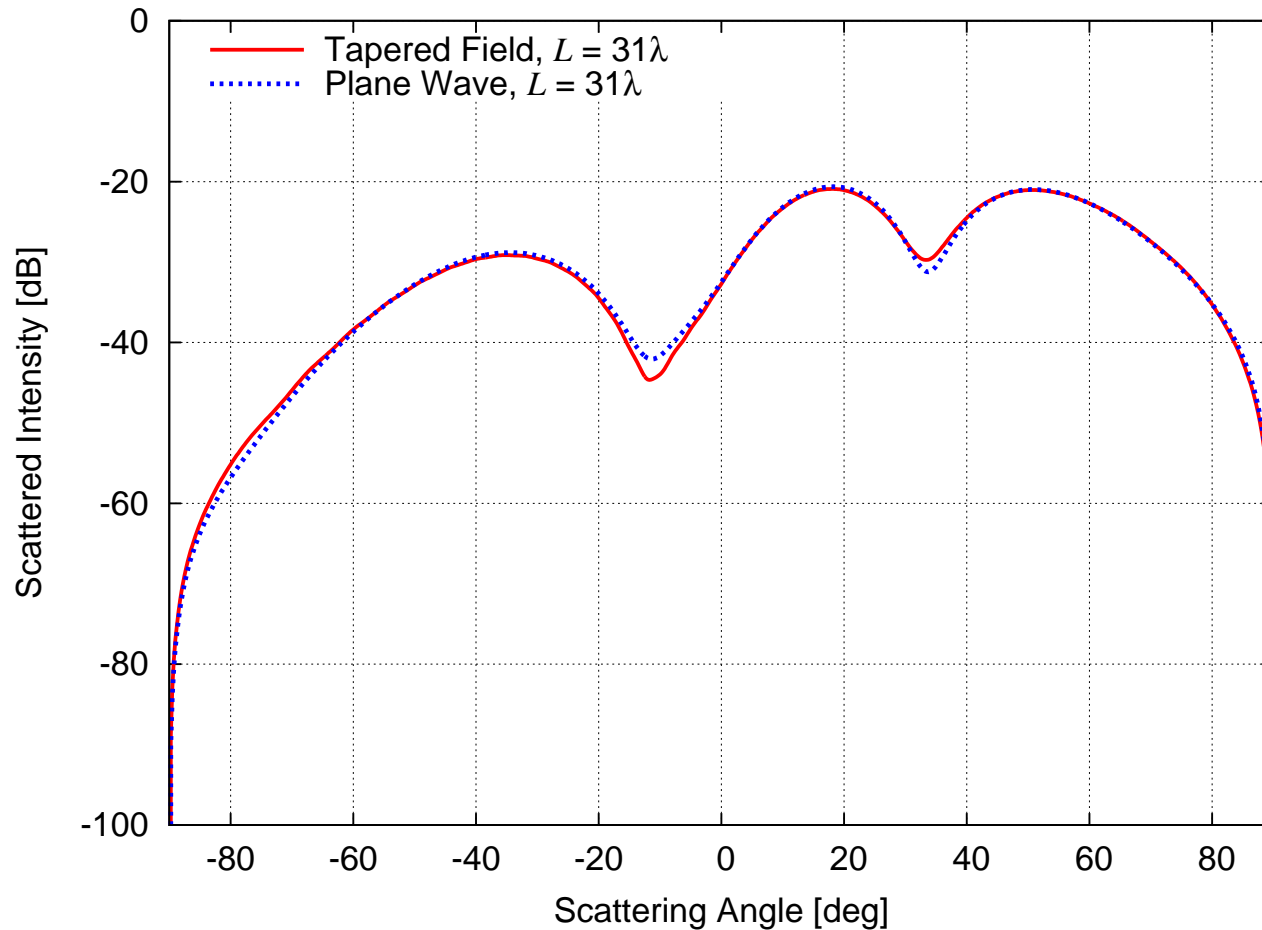
45° incidence; surface length 31λ ; beam waist size 5λ

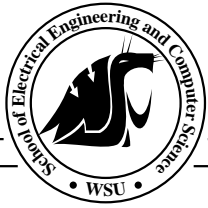




Scattering from a Notched Surface, II

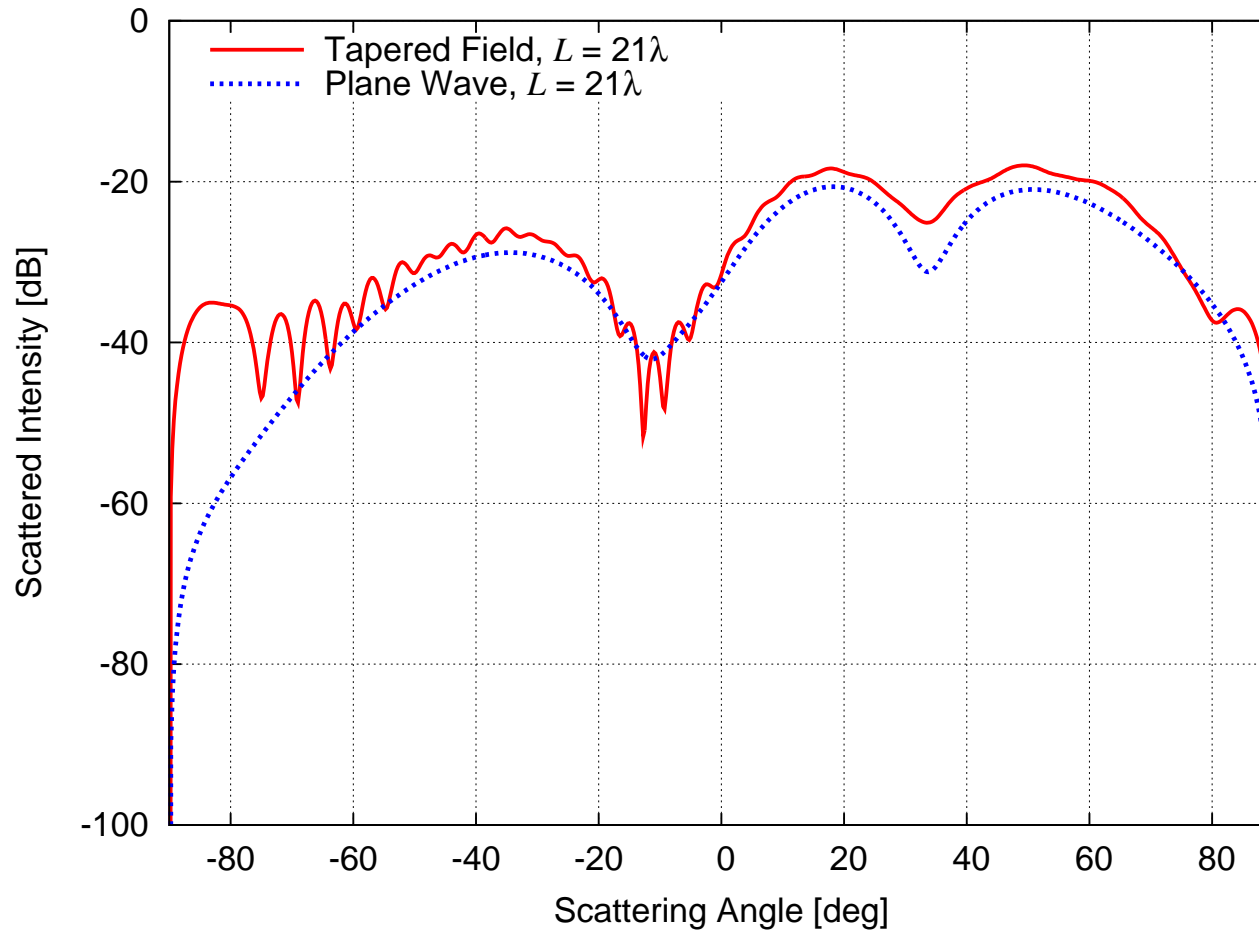
45° incidence; surface length 31λ ; beam waist size 5λ





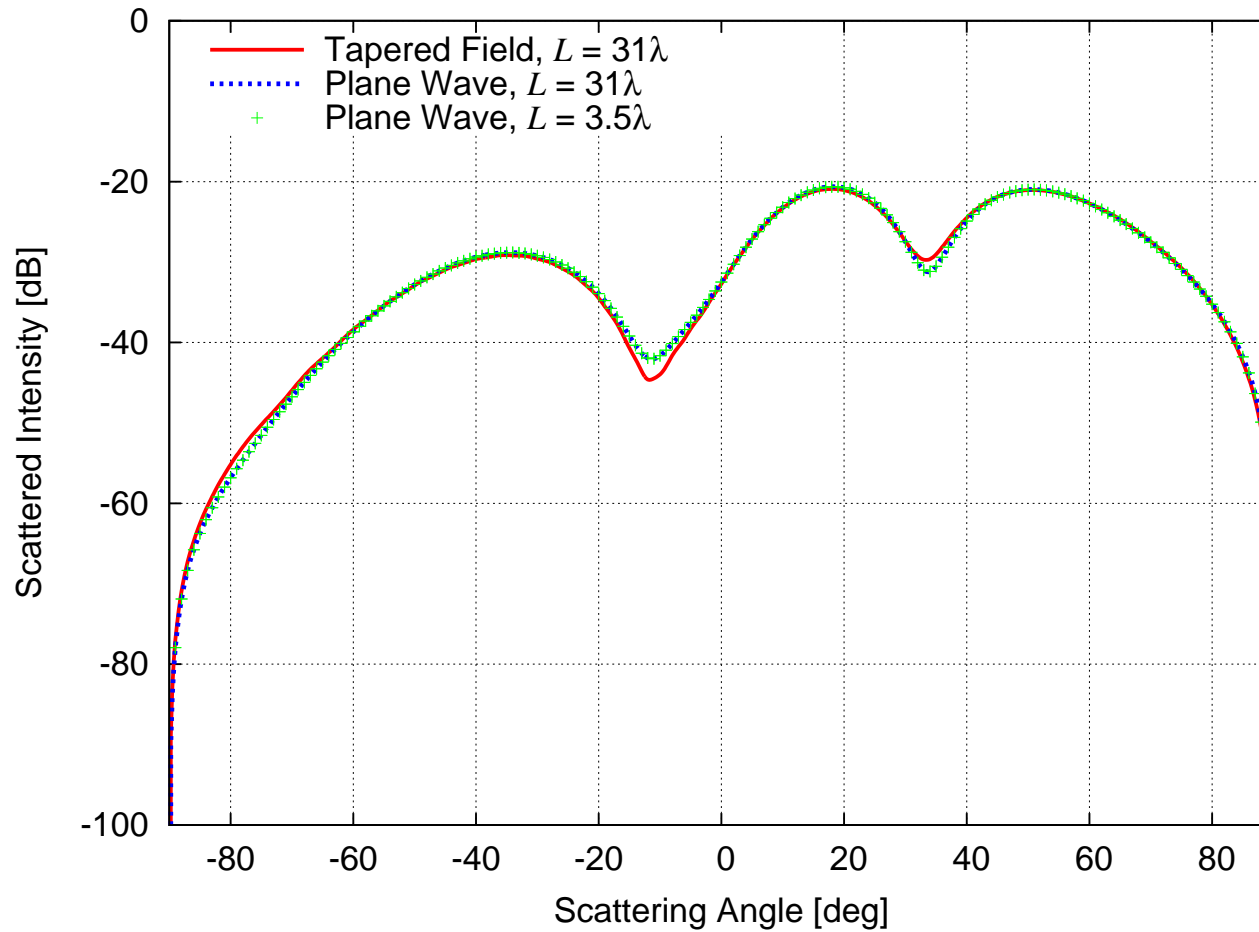
Scattering from a Notched Surface, III

45° incidence; surface length 21λ ; beam waist size 5λ



Scattering from a Notched Surface, IV

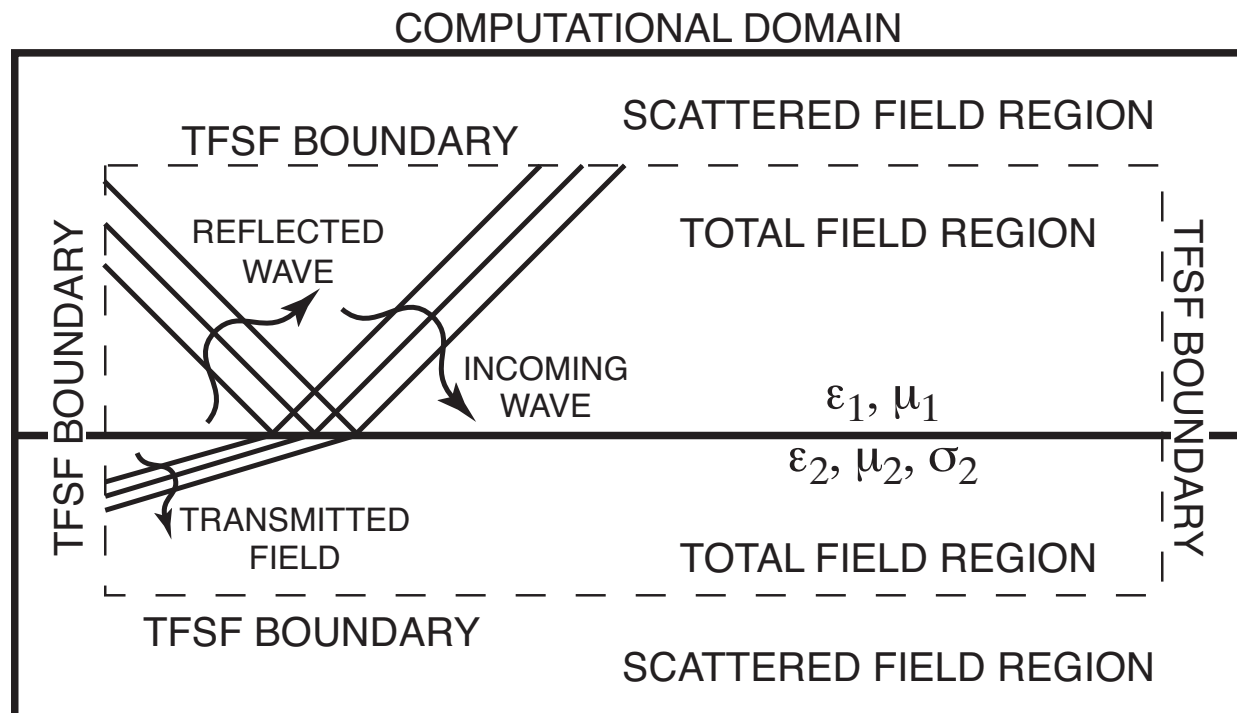
45° incidence; surface length 31λ or 3.5λ



Dielectric Halfspaces

Incident field specified at TFSF boundary consists of:

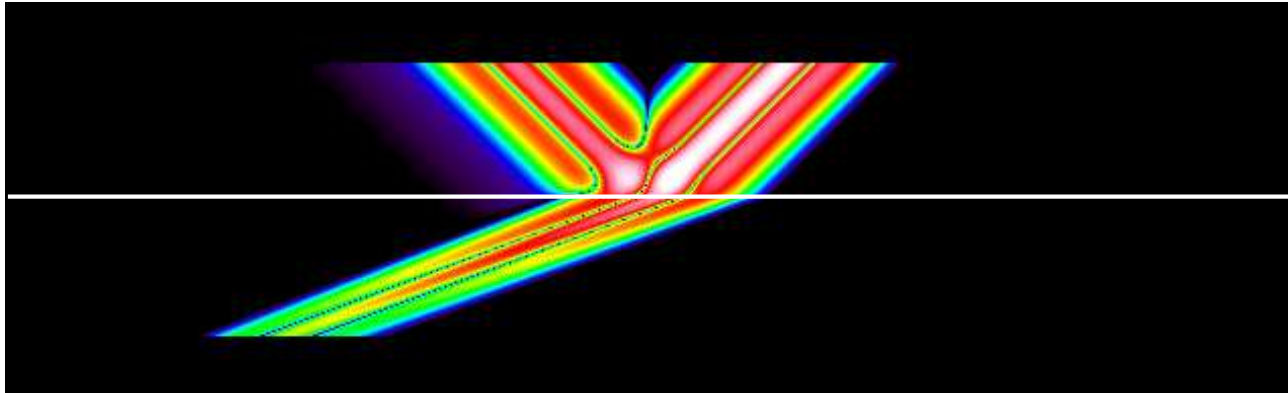
- (1) incoming plane wave **and**
- (2) corresponding reflected plane wave **and**
- (3) corresponding transmitted field (may be evanescent)



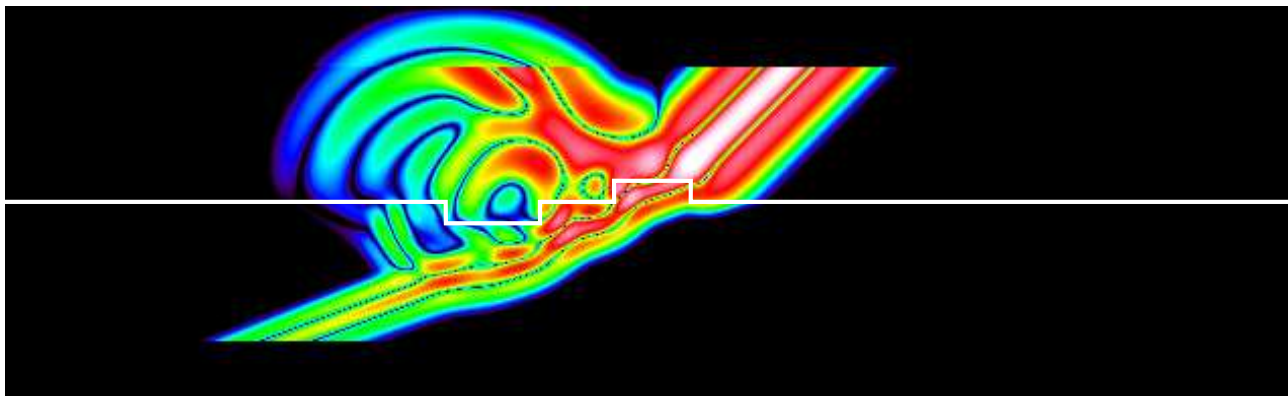
Plane Wave Incidence for Dielectric Surface

$$\epsilon_{1r} = 1, \mu_{1r} = 1, \text{ lossless}$$

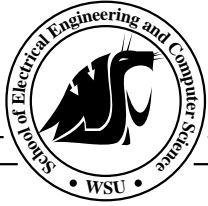
$$\epsilon_{2r} = 4, \mu_{2r} = 1, \delta_{\text{skin}} = 0.575\lambda \text{ at 40 points per wavelength}$$



Flat surface: no fields enter
SF region



Notched surface: scattered
field present



Scattering from Pierson-Moskowitz Surface, I

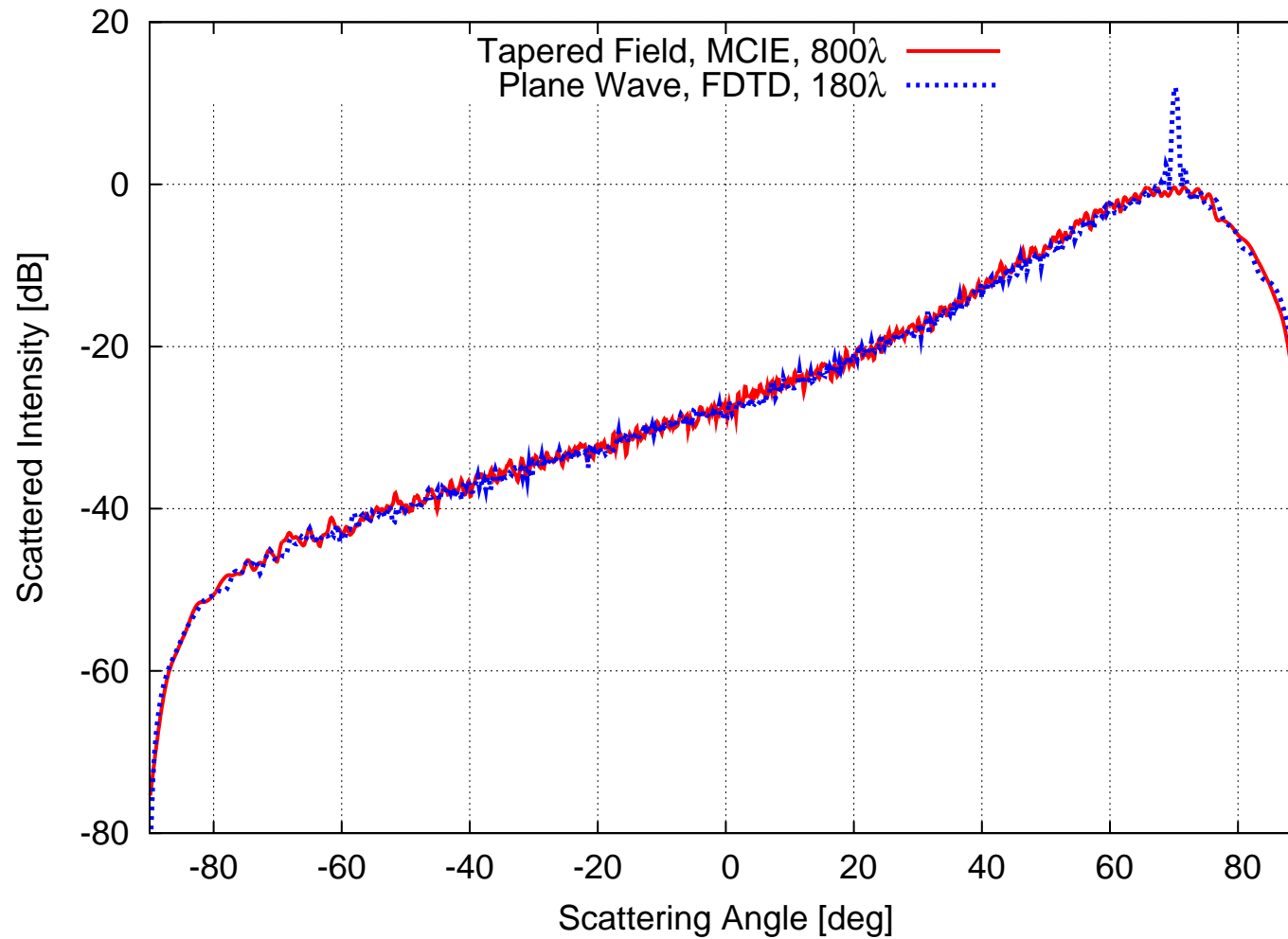
Results obtained using:

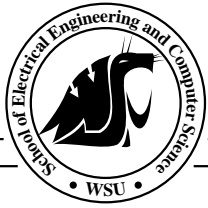
1. Monte Carlo Integral Equation (MCIE) with tapered field
2. FDTD with plane wave

Parameters:

- Wind speed 10 m/s
- 300 MHz
- 70° incident angle
- Points per wavelength: 10 for MCIE; 30 for FDTD
- Surface length: 800λ for MCIE; 180λ for FDTD
- 50 surface realizations
- Dirichlet boundary condition (conducting surface with TM^z polarization)

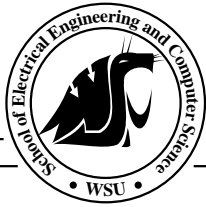
Scattering from Pierson-Moskowitz Surface, II





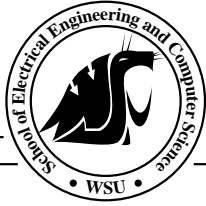
Conclusions

- Can use plane wave illumination with FDTD method to study scattering from rough surfaces
- Plane-wave approach can be more efficient than using tapered illumination
- Plane-wave approach eliminates several problems associated with tapered illumination
- Can be used for conducting or dielectric surfaces
- Can be used for 3D problems
- Total-field region may include any desired combination of inhomogeneities



References, I

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2. J. C. West, “On the Control of Edge Diffraction in Numerical Rough Surface Scattering Using Resistive Tapering,” *IEEE Trans. Antennas Propag.*, **51**(11):3180–3183, 2003
3. Z. Zhao, L. Li, J. Smith, L. Carin, “Analysis of Scattering from Very Large Three-Dimensional Rough Surfaces Using MLFMM and Ray-Based Analysis,” *IEEE Antennas Propag. Mag.*, **47**(3):20–30, 2005
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5. Martin, Pettersson, “Modified Fresnel Coefficients for Huygens’ Sources in FDTD,” *ACES J.*, **17**(1):30-41, 2002
6. C. D. Moss, F. L. Teixeira, and J. A. Kong, “Analysis and compensation of numerical dispersion in the FDTD method for layered, anisotropic media,” *IEEE Trans. Antennas Propagat.*, **50**(9):1174–1184, 2002
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8. K. Abdijalilov and J. B. Schneider, “Analytic Field Propagation TFSF Boundary for FDTD Problems Involving Planar Interfaces: Lossy Material and Evanescent Fields,” *IEEE Antennas Wireless Propagat. Lett.*, **5**:454–458, 2006